

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/770,148	HUBER ET AL.	
Examiner	Art Unit	
David E. Martinez	2181	

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SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East see attached	6/23/2006	DM	
eDan Inventor Search	6/23/2006	DM	
710/62,72,300,303.ccls. with keywords and textsearch	6/23/2006	DM	
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	6/23/2006	DM	
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